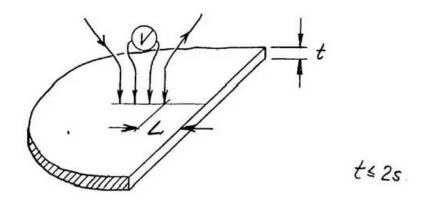
E.3) Probe Array Perpendicular to Edge, Thin Sample.



When the sample is thin, it is convenient to express the resistivity as follows:

$$Q = G_{\overline{1}}^{\underline{V}}, \qquad G = \frac{\mathcal{N}}{\overline{\ln 2}} \cdot t \cdot D_{3}(\frac{L}{s}) \cdot F_{2}(\frac{t}{s}, \frac{L}{s})$$
 (13)

where

 $\frac{\pi}{\ln 2}$ t = 4.5324 t is the geometric factor for an infinite slice of thickness t4s,

$$D_{3}(\frac{L}{s}) = \frac{1}{1 + \frac{1}{2 \ln 2} \ln \frac{(\frac{L}{s} + 2) (\frac{L}{s} + 1)}{(\frac{L}{s} + \frac{5}{2}) (\frac{L}{s} + \frac{1}{2})}}$$
(14)

is the additional correction to apply when measuring at a distance L from the edge.

$$D_3(\frac{L}{s}) \longrightarrow 1 \text{ as } \frac{L}{s} \rightarrow \infty$$

 $F_2(\frac{t}{s},\frac{L}{s})$ deviates from unity when the thickness t of the slice becomes comparable to the probe distance s.